# GP2TD03/GP2TD04

#### Features

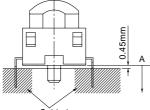
- 1. With built-in lens
- 2. Compact
- 3. Linear output current can be obtained in conformance with tilt angle.

#### Applications

- 1. LD players
- 2. DVD players

■ Absolute Maximum Ratings (Ta=25°C)								
Parameter		Symbol	Rating	Unit				
Input	Forward current	IF	50	mA				
	Reverse voltage	VR	6	V				
	Power dissipation	PD (IN)	75	mW				
Output	Reverse voltage	VR	20	V				
	Power dissipation	PD(OUT)	75	mW				
Operating temperature		Topr	-10 to +70	°C				
Storage temperature		Tstg	-40 to +85	°C				
*1Soldering temperature		T <sub>sol</sub>	260	°C				

\*1 For 5s below the tie bar cut part (0.45mm from the face A).

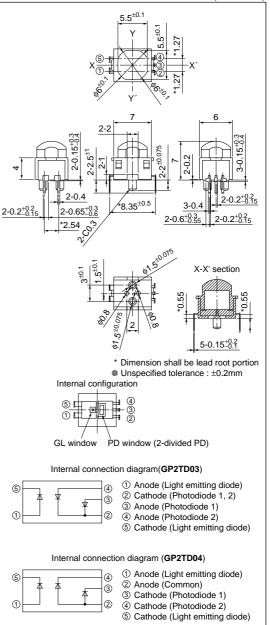


Soldering area

## **Tilt Sensor for Optical Disk**

#### Outline Dimensions

(Unit:mm)



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#### ... . ...

Election	ro-optical Charact	eristics	5				(	Ta=25°C)
Parameter			Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input (Emitter)	Forward voltage		VF	IF=17mA	-	1.25	1.5	V
	Reverse current		Ir	Vr=6V	-	-	10	μA
	Peak sensitivity wavelength		$\lambda p_1$	_	-	950	-	nm
	Spectrum radiation bandwidth		Δλ	-	-	45	-	nm
Output (Detector)	*2Dark current (Each PD)		Id	V <sub>R</sub> =10V	_	-	100	nA
	Peak sensitivity wavelength	GP2TD03	$\lambda p_2$	_	-	960	-	nm
		GP2TD04	$\lambda p_2$	_	_	900	-	nm
	Response time	GP2TD03	tr, tr	*2 V <sub>R</sub> =1V, R <sub>L</sub> =1k $\Omega$	-	50	-	ns
		GP2TD04	tr, tr	*2 V <sub>R</sub> =1V, R <sub>L</sub> =1k $\Omega$	-	300	-	ns
	Short circuit current	GP2TD03	Isc	*3 Ev=1 000 1x	-	4.2	-	μΑ
		GP2TD04	Isc	*3Ev=1 000 1x	_	3.5	-	μΑ
Coupling - charac- teristics	*4Difference output increment rate	GP2TD03	A/deg.	$^{*4}$ Vcc=5V, H=10.0mm, $\theta$ y=-0.5 to 0 to +0.5deg.	3.3	6.6	12.87	μA/deg.
		GP2TD04	A/deg.	$^{*4}$ Vcc=5V, H=10.0mm, $\theta$ y=-0.5 to 0 to +0.5deg.	3	6	11.7	μA/deg.
	*5 Angle range of tilt angle output 0		θο	*5 Vcc=5V, H=10mm	-2	-	+2	deg.
	*6 Monotonous increase range of tilt angle output		<del>0</del> r	*6 Vcc=5V, H=10mm	1.5	_	-	deg.
	<sup>*7</sup> Non-invert range of tilt angle output		<del>O</del> t	*7 Vcc=5V, H=10mm	5.0	-	-	deg.
	*8Leak		ALEAK	*8 Vcc=5V	_	-	57	nA

\*2 Measuring method of response time, refer to Fig.1

\*3 EV : Illuminance by CIE standard light source A (tungsten lamp).

\*4 Difference output A stands for A=ISC (PD1)-ISC (PD2).

Difference output increment rate (A/deg.) shall be the current increase rate of A for 1deg.

[{ISC (PD1)-ISC (PD2)} at (+0.5deg.)] + [{ISC (PD2)-ISC (PD1)} at (-0.5deg.)]

\*5 The subtraction output zero angle region shall be the range of the angle at which A is zero.

\*6 The angle,  $\theta$ r, which monotonously increases when the angle at which A is zero is assumed to be zero.

\*7 The subtraction output non-reversing region shall be the angle,  $\theta$ t, when the angle which A is zero is assumed to be zero.

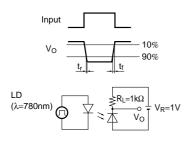
\*8 ALEAK applies to the value of A measured without reflective object.

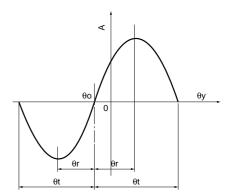
\*9 The measurement of \*4 to \*8 shall be or test circuit in accordance with Fig.8 and Fig.9.

\*10 Reflective objected used in test for coupling characteristics shall be multi-layer coating mirror (NIPPON SHINKU KOGAKU made mirror of reflectance of 95% min. at 950nm). The test circuit and the coordinate system shall be as shown in Fig.8 and Fig.9. It shall be assumed that there is no deviation in the directions X and Y.

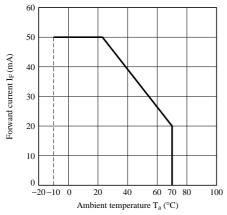
#### Fig.1 Test Circuit for Response Time

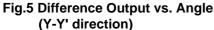
#### **Fig.2 Subtraction Output**

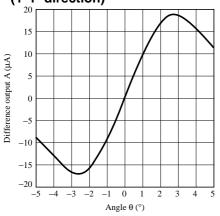




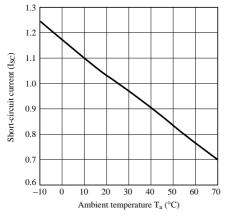
#### Fig.3 Forward Current vs. Ambient Temperature



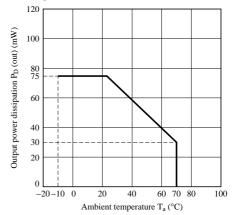




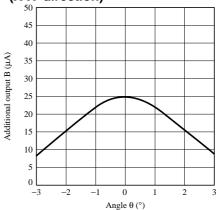




#### Fig.4 Output Power Dissipation vs. Ambient Temperature

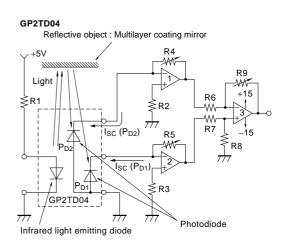


## Fig.6 Additional Output vs. Angle (X-X' direction)



#### Fig.8 Example of Test Circuit

#### GP2TD03 Reflective object : Multilayer coating mirror R4 +5V 11 R9 Light JAA +15R6 ≷R1 R2 w 3 -~~~ R7 I<sub>SC</sub> (P<sub>D2</sub>) -15 R5 ş AAX **R**8 777 2 Isc (PD1) ∕ŚR3 GP2TD03 777 777 77 Photodiode Infrared light emitting diode



 $\begin{array}{l} {\sf R1:220\Omega} \\ {\sf R2,R3,R6,R7,R8:10k\Omega} \\ {\sf R4,R5:220k\Omega\ to\ 10M\Omega\ (optional)} \\ {\sf R9:10k\Omega\ to\ 100k\Omega\ (optional)} \\ {\sf OPAMP:1,2,3} \end{array}$ 

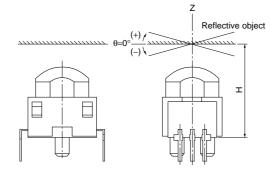
Arrows indicate current directions

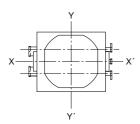
Above sample circuits are the model circuit, which amplitude and calculate the signals.

Output is determined by the constant of resistance.

Specifications above are calculated using output current.

### Fig.9 Coordinate System





Definition of  $\theta=0^{\circ}$ : Surface parallel to the reference plane A of this reflection type photointerrupter defined by the equation Z=H (H=10mm) shall be taken as a  $\theta=0^{\circ}$  surface. The clockwise direction of rotation of a reflective object located at  $\theta=0^{\circ}$  around the X-axis shall be the  $\theta(+)$  rotational direction. The counterclockwise direction of its rotation shall be the  $\theta(-)$  rotational direction.

#### Precautions for Use

#### 1. Cleaning

Polycarbonate resin is used as the material of the lens surface. As to cleaning, this reflective type photointerrupter shall not be cleaned by cleaning materials absolutely. Dust and stain shall be cleaned by air blow, or shall be cleaned by soft cloth soaked in washing materials.

2. Reduction of light emitting diode output

In circuit designing, make allowance for the degradation of the light emitting diode output that results from long continuous operation. (50% degradation / 5years)

3. Soldering

To solder onto lead pins, solder at the position of 0.45mm or more from the package's bottom at 260°C for 5s or less. Please don't bend lead pins from the root of package when soldering. And please take care not to let any external force exert on lead pins. Please don't do soldering with preheating, and please don't do soldering by reflow.

4. Positioning pin

This reflection type photointerrupter is positioned in the directions X and Y of the coordinate system shown in Fig.9 by means of two  $\phi$ 1.5mm pins of 2-mm height.

Do not heat stake the positioning pin because it affects the reliability of the internal element adversely. To fix the pin, use adhesives unlikely to erode this reflection type photointerrupter such as epoxy and silicone type adhesives.

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